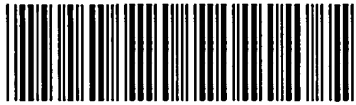


Search Notes

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10/757,253

Examiner

Hsien-ming Lee

Applicant(s)/Patent under
Reexamination

EPPICH ET AL.

Art Unit

2823

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST attached (USPAT)	7/22/2006	LEE